

SANYO Semiconductors DATA SHEET

2SJ630 — General-Purpose Switching Device Applications

Features

- · Low ON-resistance.
- · Ultrahigh-speed switching.
- · 1.8V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		-12	V
Gate-to-Source Voltage	VGSS		±8	V
Drain Current (DC)	ΙD		-6	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	-24	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (600mm ² X0.8mm)	1.5	W
		Tc=25°C	3.5	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			1.114
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=-1mA, VGS=0V	-12			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =-12V, V _{GS} =0V			-10	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±6.4V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	V _{DS} =-6V, I _D =-1mA	-0.3		-1.0	V
Forward Transfer Admittance	yfs	V _{DS} =-6V, I _D =-3A	5.7	9.5		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	ID=-3A, VGS=-4.5V		45	58	mΩ
	RDS(on)2	ID=-1.5A, VGS=-2.5V		57	80	mΩ
	R _{DS} (on)3	I _D =-0.3A, V _G S=-1.8V		78	112	mΩ
Input Capacitance	Ciss	V _{DS} =-6V, f=1MHz		940		pF
Output Capacitance	Coss	V _{DS} =-6V, f=1MHz		230		pF
Reverse Transfer Capacitance	Crss	V _{DS} =-6V, f=1MHz		180		pF
Turn-ON Delay Time	t _d (on)	See specified Test Circuit.		12		ns
Rise Time	tr	See specified Test Circuit.		143		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		71		ns
Fall Time	tf	See specified Test Circuit.		89		ns

Marking: MD Continued on next page.

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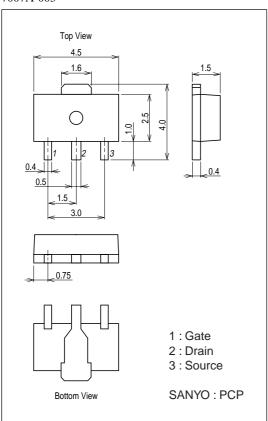
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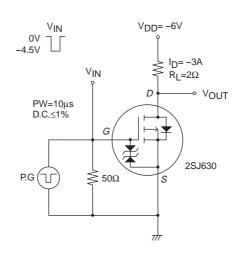
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Total Gate Charge	Qg	V _{DS} =-6V, V _{GS} =-4.5V, I _D =-6A		11		nC
Gate-to-Source Charge	Qgs	V _{DS} =-6V, V _{GS} =-4.5V, I _D =-6A		1.6		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =-6V, V _{GS} =-4.5V, I _D =-6A		2.8		nC
Diode Forward Voltage	VSD	IS=-6A, VGS=0V		-0.95	-1.5	V

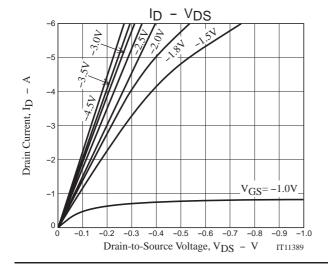
Package Dimensions

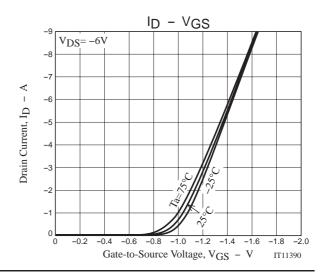
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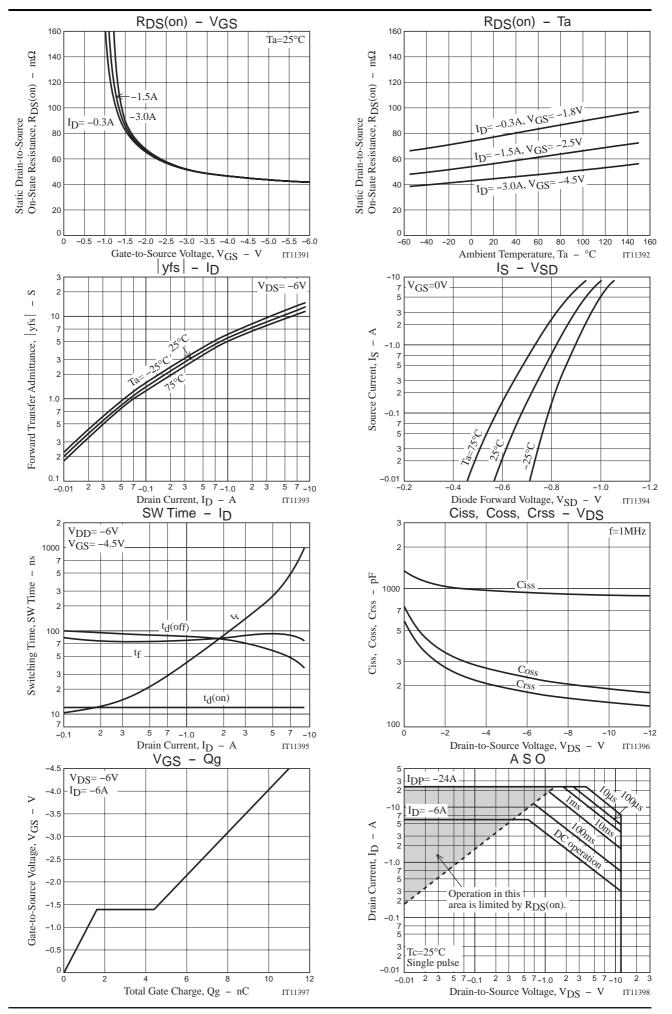


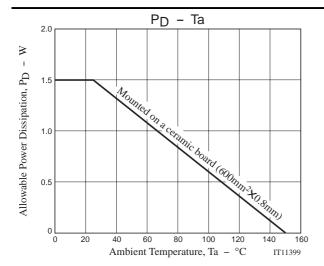
Switching Time Test Circuit

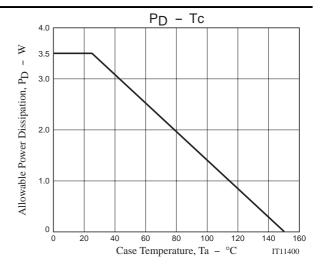












Note on usage: Since the 2SJ630 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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